## Applicant(s)/Patent Under Application/Control No. Reexamination 10/686,711 OKANO ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 3744 Chen-Wen Jiang **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY SHINKAI, SEIICHI JP 57150789 A 09-1982 Japan Ν 0 Р Q R S т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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